Notice of References Cited Application/Control No. 10/602,163 Examiner Don P Le Applicant(s)/Patent Under Reexamination PARK ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,713,162	03-2004	Takaya et al.	428/209
	В	US-6,643,924	11-2003	Hirabayashi, Takayuki	29/846
	С	US-6,170,154	01-2001	Swarup, Arvind	29/830
	D	US-6,191,666	02-2001	Sheen, Jyh-Wen	333/185
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-		'	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
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	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	>			
	>	•		
	X			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.